S	earch l	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,736	YIN ET AL.	
Examiner	Art Unit	
Christian Wilson	2891.	

SEARCHED			
Class	Subclass	Date	Examiner
438	680	1/19/2006	2000
	780		
	781		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text (USPAT, PGPUB, IBM)	1/19/2006	D W
STN (INSPEC, CAPLUS)		